

**Search Notes**

Application/Control No.

10/620,051

Examiner

Adolf Berhane

Applicant(s)/Patent under  
Reexamination

YIM, MAU SHIN FRANK

Art Unit

2838

**SEARCHED**

Class	Subclass	Date	Examiner
363	37		
	56.01		
	80		
307	64		
	66	3/3/2005	AB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
307	66	3/3/2005	AB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR